

<b>Notice of References Cited</b>	Application/Control No. 10/510,996	Applicant(s)/Patent Under Reexamination RILEY ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2007/0296600 A1	12-2007	Dixon et al.	340/573.1
	B	US-7,296,312 B2	11-2007	Menkedick et al.	5/611
	C	US-7,089,612 B2	08-2006	Rocher et al.	5/613
	D	US-2006/0168731 A1	08-2006	Menkedick et al.	005/618
	E	US-2006/0168730 A1	08-2006	Menkedick et al.	005/618
	F	US-2006/0162079 A1	07-2006	Menkedick et al.	005/624
	G	US-2006/0107459 A1	05-2006	Gladney, Richard F.	005/424
	H	US-2006/0080777 A1	04-2006	Rocher et al.	005/618
	I	US-2006/0010601 A1	01-2006	Riley et al.	005/600
	J	US-6,983,499 B2	01-2006	Gladney, Richard F.	5/424
	K	US-2005/0172405 A1	08-2005	Menkedick et al.	005/618
	L	US-2005/0166324 A1	08-2005	Dixon et al.	005/616
	M	US-2005/0035871 A1	02-2005	Dixon et al.	340/686.1

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

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	U	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0231052 A1	11-2004	Gladney, Richard F.	005/424
	B	US-6,791,460 B2	09-2004	Dixon et al.	340/573.1
	C	US-2002/0080037 A1	06-2002	Dixon et al.	340/573.1
	D	US-6,320,510 B2	11-2001	Menkedick et al.	340/573.1
	E	US-6,208,250 B1	03-2001	Dixon et al.	340/573.1
	F	US-5,758,371	06-1998	VanDyke et al.	5/86.1
	G	US-5,495,228	02-1996	Futsuhara et al.	340/507
	H	US-5,317,769	06-1994	Weismiller et al.	5/610
	I	US-5,468,216	11-1995	Johnson et al.	601/24
	J	US-5,181,288	01-1993	Heaton et al.	5/607
	K	US-5,156,166	10-1992	Sebring, John P.	5/608
	L	US-4,960,271	10-1990	Sebring, John P.	5/608
	M	US-4,837,877	06-1989	Hamada et al.	5/10.2

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,645,920	02-1987	Carroll et al.	250/221
	B	US-4,552,403	11-1985	Yindra, Leonard J.	297/330
	C	US-4,534,077	08-1985	Martin, Kelly D.	5/424
	D	US-4,520,262	05-1985	Denton, Anthony D.	250/221
	E	US-4,463,463	08-1984	Kaneko, Kenichi	5/616
	F	US-4,403,214	09-1983	Wolar, William	340/540
	G	US-4,325,061	04-1982	Wolar, William	340/679
	H	US-3,970,846	07-1976	Schofield et al.	250/221
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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